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Vishay Siliconix

P-Channel 20 V (D-S) MOSFET



PRODUCT SUMMARY				
V _{DS} (V)	-20			
$R_{DS(on)}$ max. (Ω) at V_{GS} = -4.5 V	0.0140			
$R_{DS(on)}$ max. (Ω) at V_{GS} = -2.5 V	0.0200			
$R_{DS(on)}$ max. (Ω) at V_{GS} = -1.8 V	0.0300			
Q _g typ. (nC)	39			
I _D (A)	-15.4 ^e			
Configuration	Single			

FEATURES

- TrenchFET® Gen III p-channel power MOSFET
- 1.8 V rated R_{DS(on)}
- 100% R_q tested
- Material categorization: for definitions of compliance please see www.vishav.com/doc?99912



RoHS COMPLIANT

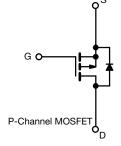
HALOGEN FREE

APPLICATIONS

- Adapter switch
- · Load switch
- DC/DC converters
- High speed switching

wearable devices

 Power management in battery-operated, mobile and



ORDERING INFORMATION				
Package	SO-8			
Lead (Pb)-free and halogen-free	Si4403DDY-T1-GE3			
ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted)				

ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted)					
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-source voltage		V _{DS}	-20	V	
Gate-source voltage		V_{GS}	± 8	7 v	
Continuous drain current (T _J = 150 °C)	T _C = 25 °C		-15.4 ^e		
	T _C = 70 °C	Ι.	-12.3	1	
	T _A =25 °C	l _D	-10.9 ^{b, c}	1	
	T _A = 70 °C		-8.7 b, c	Α	
Pulsed drain current (t = 100 μs)		I _{DM}	-32 ^a		
Continuous source-drain diode current	T _C = 25 °C	Is	-4.2	1	
	T _A = 70 °C		-2 b, c	1	
Maximum power dissipation	T _C = 25 °C		5		
	T _C = 70 °C	P _D	3.2		
	T _A = 25 °C		2.4 b, c	W	
	T _A = 70 °C		1.5 ^{b, c}	1	
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +150	°C	
Soldering recommendations (peak temperature)			260	1 "	

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum junction-to-ambient b, d	t ≤ 10 s	R _{thJA}	41	52	°C/W	
Maximum junction-to-foot (drain)	Steady state	R _{thJF}	20	25	C/VV	

Notes

- a. Package limited
- b. Surface mounted on 1" x 1" FR4 board
- c. t = 10 s
- d. Maximum under steady state conditions is 100 °C/W
- e. $T_C = 25$ °C

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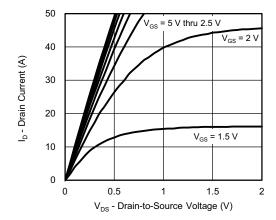
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Static				l.			
Drain-source breakdown voltage	V_{DS}	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-20	-	-	V	
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$		-	-12.5	-		
V _{GS(th)} temperature coefficient	$\Delta V_{GS(th)}/T_J$	$I_D = -250 \mu A$	-	26.5	-	mV/°C	
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-0.4	-	-1	V	
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$	-	-	± 100	nA	
Zero gate voltage drain current		V _{DS} = -20 V, V _{GS} = 0 V	-	-	-1		
	I _{DSS}	V _{DS} = -20 V, V _{GS} = 0 V, T _J = 55 °C	-	-	-10	μΑ	
On-state drain current ^a	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = 0 \text{ V}$	-5	-	-	Α	
	2(0.1)	V _{GS} = -4.5 V, I _D = -9 A	-	0.0105	0.0140		
Drain-source on-state resistance ^a	R _{DS(on)}	V _{GS} = -2.5 V, I _D = -6 A	-	0.0140	0.0200	Ω	
	20(01)	$V_{GS} = -1.8 \text{ V}, I_D = -3 \text{ A}$	-	0.0190	0.0300	- "	
Forward transconductance a	g _{fs}	$V_{DS} = -10 \text{ V}, I_D = -9 \text{ A}$	-	45	-	S	
Dynamic ^b	313	20 4 7 2	<u> </u>				
Input capacitance	C _{iss}		T -	3250	_	pF	
Output capacitance	Coss	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	_	340	-		
Reverse transfer capacitance	C _{rss}		_	325	_		
	-155	V _{DS} = -10 V, V _{GS} = -8 V, I _D = -5 A	_	66	99		
Total gate charge	Q_g	$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -5 \text{ A}$	_	39	59		
Gate-source charge	Q _{qs}	VDS = 10 V, VGS = 4.0 V, ID = 071	_	3.7	-	nC	
Gate-drain charge	Q _{ad}	$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V}, I_D = -5 \text{ A}$	_	7.9	_		
Gate resistance	R _a	f = 1 MHz	0.7	3.7	7.4	Ω	
Turn-on delay time	t _{d(on)}		-	21	40		
Rise time	t _r	V_{DD} = -10 V, R_L = 2 Ω , $I_D \cong$ -5 A,	_	25	50		
Turn-off delay time	t _{d(off)}	$V_{\text{DD}} = -10 \text{ V}, \text{ R}_{\text{L}} = 2.2, \text{ R}_{\text{D}} = -3 \text{ A},$ $V_{\text{GEN}} = -4.5 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$	_	70	140		
Fall time	t _f	3	_	24	50		
Turn-on delay time	t _{d(on)}		-	9	20	ns	
Rise time	t _r	V_{DD} = -10 V, R_L = 2 Ω , $I_D \cong$ -5 A,	_	18	35	- - -	
Turn-off delay time	t _{d(off)}	$V_{GEN} = -8 \text{ V}, R_q = 1 \Omega$	_	74	150		
Fall time	t _f	3	_	20	40		
Drain-Source Body Diode Characteristi						<u> </u>	
Continuous source-drain diode current	I _S	T _C = 25 °C	_	_	-5.2		
Pulse diode forward current	I _{SM}	-0 20 0	_	-	-32	Α	
Body diode voltage	V _{SD}	I _S = -5 A, V _{GS} = 0 V	_	-0.8	-1.2	V	
Body diode reverse recovery time	t _{rr}	15 - 071, 165 - 01	_	31	60	ns	
Body diode reverse recovery time	Q _{rr}	-	_	20	40	nC	
Reverse recovery fall time	 	$I_F = -5 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$	_	12	-	110	
neverse recovery fall tillle	ta		_	14	ı -	ns	

Notes

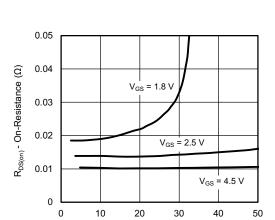
- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%$
- b. Guaranteed by design, not subject to production testing

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



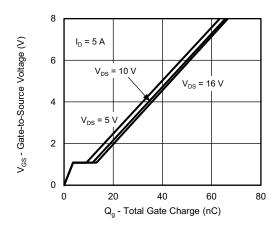


Output Characteristics

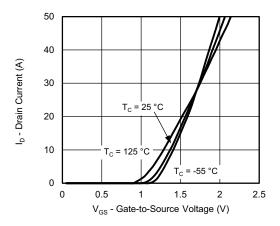


On-Resistance vs. Drain Current and Gate Voltage

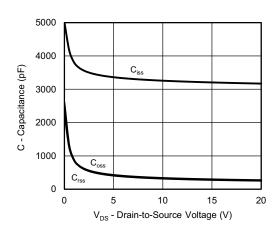
I_D - Drain Current (A)



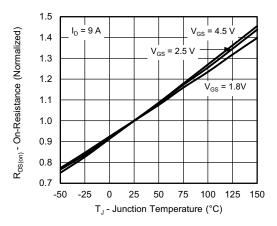
Gate Charge



Transfer Characteristics

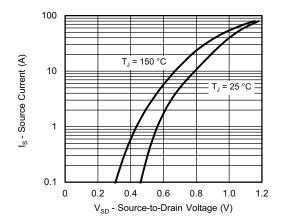


Capacitance

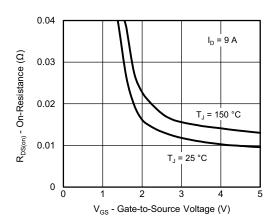


On-Resistance vs. Junction Temperature

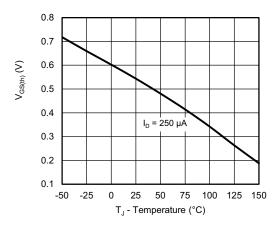




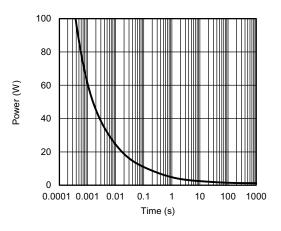
Source-Drain Diode Forward Voltage



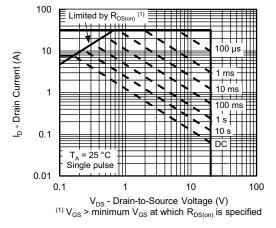
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage

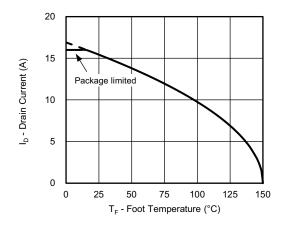


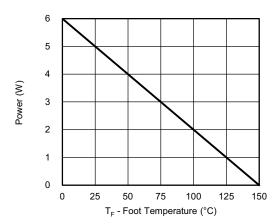
Single Pulse Power, Junction-to-Ambient



Safe Operating Area, Junction-to-Ambient







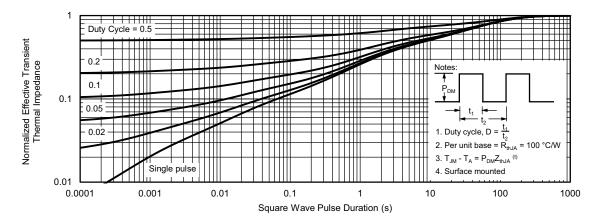
Power, Junction-to-Foot

Current Derating a

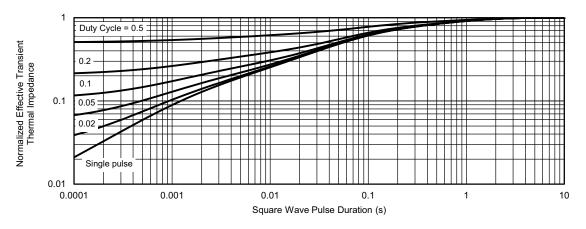
Note

a. The power dissipation P_D is based on T_J max. = 25 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

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